Application/Control No. Applicant(s)/Patent Under Reexamination 10/799,778 NAKAMURA ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 1751 Mark Kopec **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 06-1985 252/512 US-4,521,329 Siuta et al. Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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